Evanescently coupled mid-infrared photodetector for integrated sensing applications: Theory and design

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ABSTRACT

We present theory and simulation of a mid-infrared (λ = 3.2 μm) chalcogenide waveguide monolithically integrated with an evanescently coupled PbTe photodetector for lab-on-a-chip sensing applications. A spacer layer is used to modify effective index of the structure, enabling a waveguide-detector mode to propagate in the chalcogenide waveguide and be absorbed in the PbTe detector. The relation between quantum efficiency and detector dimensions is analyzed showing that the design geometry can be optimized to maximize signal to noise ratio. In addition, the location of metal contacts is optimized to minimize loss while maintaining good device performance. The design is compatible with standard planar lithographic processing and its flexibility suggests multiple applications in the fields of biological and chemical sensing.

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1. Introduction

IR spectroscopy for the identification of biological and chemical agents is usually performed in the “fingerprint” midwave-infrared (MWIR) bands from 3 to 5 μm and 8 to 12 μm where most molecules show characteristic vibrational absorption features. Rapid sensing and detection with high sensitivity in a small footprint can be achieved by the integration of various functional elements (mid-IR light source, sensing element, detector, and read-out circuits) onto a monolithic, planar silicon platform as schematically illustrated in Fig. 1. Smaller device footprints can lead to new and important applications such as remote deployment of arrays of integrated mid-IR sensor devices that can record and relay data from sensing events without human intervention.

Although there have been successful demonstrations of mid-IR and far-IR transmission and sensing with III–V waveguides (GaAs/AlGaAs) [1,2] and silver halides (AgBr/AgCl) [3], they remain low-index contrast systems with high cost (III–V systems grown using MOCVD/MBE) or feature high sidewall roughness (silver halide) in single-mode designs. Chalcogenide glasses (ChGs) have recently been demonstrated as a promising platform for mid-IR chemical and biological sensing [4] since they exhibit transparency over a large range of mid-IR wavelengths and tunable optical properties through doping and/or compositional tailoring [5]. A CMOS-backend-compatible process can be employed to fabricate ChG-based planar devices on a silicon platform [6], reducing the cost and footprint when compared to traditional chemical and biological sensors.

Broadband infrared (IR) detectors such as those based on HgCdTe have been extensively used in IR spectroscopy [7] – they are typically single-crystalline and are obtained by high-cost growth techniques such as metal organic chemical vapor deposition (MOCVD) and molecular beam epitaxy (MBE) [8]. We have recently demonstrated a thin film lead telluride (PbTe) photoductor as an efficient on-chip IR detector of choice due to: (a) the ease of deposition of single-phase, stoichiometric polycrystalline PbTe films using low cost thermal evaporation techniques and (b) for its superior chemical stability [9,10]. Also, a resonant-cavity-enhanced dual band mid-IR detector has recently been demonstrated using PbTe as the active absorber [11].

Our integrated sensor approach uses vertical evanescent coupling from ChG waveguides (As2Se3) into MWIR PbTe detectors. An inherent challenge is the large index difference at λ = 3.2 μm between As2Se3 (n = 2.75) and PbTe (n = 5.2) which is addressed by the introduction of a low index spacer layer between the waveguide and detector to minimize modal mismatch and Fresnel...
reflection. Evanscently coupled detectors using hybrid integration of III–V detectors for 2.2–2.3 μm detection [12] and monolithically integrated Ge detectors for telecom wavelengths have been demonstrated [13]. However, we present here a design and simulation results for a new and important wavelength range useful in chem-bio sensing. We demonstrate a mid-IR waveguide-detector integration scheme using a ChG waveguide monolithically integrated with an MWIR PbTe photoconductive detector. Unlike their bulky off-chip counterparts, mid-IR microsensor arrays integrated with PbTe detectors can enable the low-cost, small footprint, remote detection of multiple chemical/biological species on a single silicon platform.

2. Materials and methods

2.1. Design

Fig. 2(a) shows the layout of the evanescently coupled detector and Fig. 2(b) shows a cross section of the detector waveguide system. The As2Se3 waveguide is designed for single mode operation at 3.2 μm and the GeSbS glass (n = 2.1) undercladding prevents leakage into the silicon substrate. The spacer (nominally n = 1.5) in Fig. 2(a) covers the entire sample and also functions as a planarizing layer, with the PbTe extending laterally beyond the waveguide.

Prior work has studied the responsivity of thermally evaporated polycrystalline PbTe thin films. The photoreponsivity of polycrystalline PbTe was optimized by measuring thin films of different thicknesses both, at room temperature and at thermoelectrically cooled temperatures (−60 °C or 214 K). The 100 nm thick PbTe detector layer exhibits high photoresponsivity (25 V/W) in the 3–4 μm wavelength range under a bias current of 0.1 mA at −60 °C as shown in Fig. 3 [10,14,15]. From a materials perspective, further improving the responsivity of polycrystalline PbTe films for mid-IR detection may be possible by increasing carrier lifetime or by reducing carrier concentration. For example, incorporation of oxygen in lead chalcogenide films can enhance carrier lifetimes due to spatial separation of photo-generated electrons and holes by minority carrier traps (PbO) [16–19]. The oxygen also forms acceptor states in the band gap which deplete electrons from the conduction band. Oxygen sensitization is typically achieved using high temperature (>450 °C) anneals in an oxidizing atmosphere [20,21] and for the monolithically integrated structure that we are proposing, such anneals for the PbTe layer will have detrimental effects on the ChG materials underneath. However, we have demonstrated that room temperature oxygen sensitization of PbTe is possible and leads to improved responsivity [14,15]. In this paper, we will focus on improving waveguide-detector coupling performance by optimizing the geometry of the PbTe detector layer for a high signal-to-noise ratio.

2.2. Detector theory

Detector optimization requires that we examine the physics underpinning the signal to noise ratio. The change in voltage in the illuminated portion of the photoconductor with an applied current bias is given by:

$$
\Delta V = I \times \Delta R = I \times \left[ \frac{1}{\sigma + \Delta \sigma} - \frac{1}{\sigma} \right] \frac{I}{Wt} = I \frac{1}{Wt} \times -\frac{\Delta \sigma}{\sigma^2}, \Delta \sigma < < \sigma
$$

where w and t are the width and the thickness of the photoconductor, I is the length parallel to the bias current I, ΔR is the change in
resistance, $\sigma$ is the conductivity, and we assume that PbTe exhibits long carrier lifetimes. The change in conductivity ($\Delta \sigma$) is related to changes in carrier concentration and to changes in mobility [22]:

$$\Delta \sigma = (\Delta \sigma)_{n} + (\Delta \sigma)_{\mu}$$

(2)

where $n$ and $p$ are the electron and hole concentrations, $e$ is the elementary charge, and $\mu_{n}$ and $\mu_{p}$ are the electron and hole mobilities. The change in conductivity can thus be written as the sum of the changes due to carrier concentration (first term) and the mobility (second term):

$$\Delta \sigma = (\Delta \sigma)_{n} + (\Delta \sigma)_{\mu}$$

(3)

Our PbTe photoconductive films show no change in mobility with illumination therefore the barrier modulation contribution [23] linked to the change in mobility may be ignored and we adopt number modulation theory [24], which has produced results consistent with experimental measurements on our previous photodetector devices [15]. As the lifetimes of electrons and holes in our materials are nearly equal we can equate $\Delta n$ and $\Delta p$ to express the change in the number of carriers as:

$$\Delta n = \Delta p = \frac{\tau}{\hbar c / \lambda \ln 2} \int_{0}^{w} p(w) dw \rightarrow \eta_{\text{opt}} \frac{\eta_{\text{opt}} P_{\text{opt}}}{\hbar c / \lambda \ln 2}$$

(4)

where $P_{\text{opt}}$ is total optical power sent down the waveguide (integrated over the width $w$), $\lambda$ is the wavelength of illumination, $\tau$ is the photo-generated carrier lifetime, $\eta$ is the quantum efficiency, $h$ is Planck’s constant and $c$ is the velocity of light. We can assume that incident optical power is distributed evenly along the propagation direction of the waveguide, and thus we can combine Eq. (2) and Eq. (4):

$$\Delta \sigma = \frac{\eta \lambda \tau (\mu_{n} + \mu_{p}) \eta_{\text{opt}}}{\hbar c \times \ln 2}$$

(5)

Defining the responsivity $\eta$ as the change in voltage over the incident light power ($V/W$) and setting $\sigma = e \mu_{p}$ for a $p$-type system we can combine Eq. (1) and Eq. (5) to get

$$\eta = \frac{\eta \lambda \tau (1 + b)}{\hbar c \times w^{2} \tau^{2} \mu_{p}^{2}} \rightarrow \eta \propto \eta^{2} \frac{\eta}{w^{2} \tau^{2}}$$

(6)

where $b$ is the electron-hole mobility ratio and $w$ and $t$ are the width and the thickness of photodetector. To optimize the design we focus on the dimensions of the photodetector, thus simplifying the equation. For photoconductive detectors, shot noise is non-existent and at reasonably high chopping frequencies, Johnson noise, defined as $\eta V_{\text{J}}=\sqrt{4KTR_{n}f | \Delta f |}$, is the dominant noise contributor to our detectors [15,25] where $R_{n}$ is the dark space resistance of the entire detector and $\Delta f$ is the bandwidth. We use a noise voltage because we hold current constant and measure a change in the voltage. If we assume that $\Delta \sigma \approx \sigma$, the signal-to-noise ratio (SNR) becomes:

$$\text{SNR} \propto \sqrt{\frac{\eta^{2}}{w^{2} \tau^{2} f}}$$

(7)

From Eq. (7) we see that thinner and shorter detectors maximize the SNR, but our simulations show that the quantum efficiency is also linked to detector dimensions.

### 2.3. Integrated detector simulations

For the structure shown in Fig. 2, the modes were first calculated using the commercially available mode solver FIMMProp (both by Photon Design) to study the field distribution during propagation. In addition to simulating mode behavior in the integrated structure, detailed 3D finite-difference time-domain (FDTD) simulations were also carried out with Lumerical’s FDTD Solutions package to find optimal values of the detector dimensions that lead to the highest quantum efficiency. A conformal mesh size setting of 6 was used for the entire structure with a finer mesh (10 nm) chosen for the PbTe layer due to the lower thickness. The light source in Lumerical was a single wavelength mode source at $\lambda = 3.2 \mu$m. Note that we will refer to the internal quantum efficiency of the detector as the quantum efficiency for this analysis and assume that lifetimes and current applied are held constant as we change dimensions.

### 3. Results and discussion

Fig. 4 illustrates the role of the spacer layer: Fig. 4(a) shows the field distribution with the PbTe placed directly on top of the waveguide while Fig. 4(b) demonstrates the effect of adding the spacer layer shown in Fig. 2. Without a spacer layer, the incident power is concentrated in the first 10 $\mu$m and such a design is undesirable due to high Fresnel reflection arising from the large refractive index contrast between the waveguide and detector. The addition of the spacer layer helps to extend the distance over which the field is distributed as it modifies the effective index such that the waveguide-detector mode survives longer and the field distribution is more uniform. Fig. 4(c) shows the cross-sectional profile of the waveguide-detector mode.

Fig. 5 shows the effect of varying the width and thickness of the detector on the quantum efficiency. As the width of the photoconductor is increased, more light couples into the system increasing the quantum efficiency. However, the thickness of the detector
sets the maximum quantum efficiency of the system which can be clearly seen in Fig. 5(b) where the quantum efficiency increases as the thickness of the detector increases up to 90–100 nm of thickness. A thicker film contains more of the evanescently coupled mode, thus increasing the likelihood of absorption. As films grow thicker than 100 nm the quantum efficiency decreases due to higher reflection resulting from the larger refractive index of PbTe. If the detector layer is too thin, an insufficient amount of light is absorbed which leads to lower quantum efficiency. Since a 100 nm thick film of PbTe was also demonstrated to exhibit the highest responsivity [15], 90–100 nm is chosen as the ideal thickness for our design.

These results can be inserted into Eq. (7) to evaluate the impact of the width and thickness on the device’s SNR. Fig. 6(a) shows the normalized figure-of-merit (FoM) for the SNR of the detector – smaller widths are preferable even though the quantum efficiency is reduced due to the relatively small effect of detector width on quantum efficiency and the $w^{-3/2}$ dependence of SNR on width. In Fig. 6(b) we see that the intensity of the incident light is not constant; however, if we assume that charge carriers have sufficient mobility to drift toward areas of lower concentration and that even in the highest intensity areas the $\Delta \sigma \propto \sigma$ assumption still holds true, we do not have to alter the SNR FoM.

The length of the detector (distance between electrical contacts) also affects the SNR. Eq. (7) states that a shorter detector will improve the SNR but parasitic absorption losses from metal contacts can negatively impact the quantum efficiency. From FDTD simulations we have found that a minimum separation of 750 nm between the waveguide edges and the metal contacts is required to limit the change in quantum efficiency to less than 5%. Given the geometry shown in Fig. 2(b) this pins the minimum length of our devices to about 4 $\mu$m.

The choice of an appropriate spacer layer material is contingent on it meeting the primary requirements of transparency in the wavelength range of interest and relatively low refractive index. Ease of deposition should also be a consideration so that integrity of the lower waveguide layer remains intact. With these considerations in mind, polymer materials that can be spin-coated may prove to be good choices in some wavelength ranges. However, most polymers have a backbone comprised of C–H bonds and might contain N–H and O–H bonds which all exhibit characteristic absorption peaks in the 3–3.5 $\mu$m wavelength range. Therefore, for our prototype design, in lieu of polymers, we consider inorganic compounds such as alkali halides (e.g., CaF$_2$) and amorphous alumina (Al$_2$O$_3$) as suitable for the spacer layer.

### 4. Conclusions

In summary, we have demonstrated a novel design that integrates PbTe detectors with ChG waveguides for on chip mid-IR detection. Our simulations show that the use of a spacer layer leads
to a well distributed field along the width of the detector, and that the quantum efficiency of the detector increases as the detector becomes wider. We see that thicker films lead to higher quantum efficiency up to a point but eventually changes in the non-uniformity of the field, shown that narrower detectors yield a higher FoM. We believe that such an integrated sensor design will enable the creation and deployment of low-cost remote sensor arrays with small footprints.

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References


Biographies

Vivek Singh received Bachelor of Science degrees in physics and materials science from Adelphi University and Columbia University, respectively in 2009. In the same year, he joined the Massachusetts Institute of Technology as a PhD-track graduate student in the Department of Materials Science and Engineering. His current research focuses on developing chalcogenide glass materials and microphotonic devices for mid-infrared applications.

Timothy Zens received his PhD in Materials Science and Engineering and from the Massachusetts Institute of Technology in 2011, investigating Resonant Cavity Enhanced Detection in Lead Sulfides. In 2011, he became an Assistant Professor of Materials Science, Department of Engineering Physics at the Air Force Institute of Technology. In 2012, he became the academic advisor for the Materials Science program at the Air Force Institute of Technology, where he has continued his research activities in long wavelength IR detectors from polycrystalline PbS, SnTe films; synthesis of bulk ThO2 and UO2 crystals using hydrothermal growth techniques; growth of 2D BN on graphene using molecular beam epitaxy for high power electronics; and orientation patterned infrared non-linear optical materials for infrared countermeasures and terahertz generation.

Juejun Hu received his PhD from MIT in 2009 and is currently an assistant professor in the Department of Materials Science & Engineering at the University of Delaware. His primary research interest focuses on the enhanced photon–matter interactions in nanophotonic structures, with an emphasis on on-chip spectroscopy and chemical sensing applications using novel infrared glasses. His research also covers materials and devices for magneto-optics, photovoltaics, opto-mechanics, and solid state light emitters. He has authored and co-authored over 30 refereed journal publications since 2006 and has been awarded 6 U.S. patents.

Jianwei Wang received the PhD degree in Materials Science and Engineering at Massachusetts Institute of Technology in 2010 on electronic, photonics, and magnetic materials. His research was on resonant-cavity-enhanced multispectral infrared photodetectors for monolithic integration on silicon. Additionally, he was involved in research activities in electrical and magnetic properties of NiO-based materials at Tsinghua University, where he received the Master of Engineering degree in 2005. He is currently a senior design engineer at Sensitron Semiconductor in Deer Park, NY in USA.

Dr. Musgrave conducts research on a variety of challenges in chalcogenide and telluride glasses. Current research projects include the development of glasses for use in optical waveguide devices, in fiber optic infrared light transmission, and in the precision glass molding of optical elements. Additionally, he conducts research into the evolution of glass network structure across multiple length scales, and the impact of this evolution on the resultant properties of the glass. His research in these areas combines efforts in statistics, quantum computational modeling, spectroscopic and thermal analysis in an effort to explore fundamental problems in glass science.

Kathleen Richardson received her PhD in Glass Science and Engineering and from the NYS College of Ceramics at Alfred University in 1992, investigating Defects in Low-Tg Chalcogenide Glasses. Following 7 years at the Laboratory for Laser Energetics at the University of Rochester, she went on to become an assistant professor at CREOL and the Department of Chemistry and MMAE at the University of Central Florida (UCF). In 2005, she became Director of the School of Materials Science and Engineering at Clemson University, where she continued her research activities in the area of novel optical glass and glass ceramic materials for the infrared (IR). In 2012, she returned to UCF as a Professor of Optics where she and her group carry out design and fabrication of novel infrared optical materials. She is
Lionel C. Kimerling is the Thomas Lord Professor of Materials Science and Engineering at MIT and the Director of the MIT Microphotonics Center. Prior to joining MIT, he was the head of the Materials Physics Research Department at AT&T Bell Laboratories. He earned an S.B. in Metallurgical Engineering and a PhD in Materials Science at MIT. He had a fundamental impact on the understanding of the chemical and electrical properties of defects in semiconductors and has pioneered the field of silicon microphotonics. He has been the recipient of several awards and honors and has published more than 300 research articles.

Dr. Anu Agarwal is a Principal Research Scientist at MIT’s Microphotonics Center. Her current work centers on the mid-IR (MIR) regime. Although previous silicon microphotonics devices predominantly utilized the NIR range, the MIR regime is extremely interesting for hyperspectral imaging and chem-bio sensing because most chemical and biological toxins have their fingerprints in this range. Her work on MIR materials and devices is creating a planar, integrated, Si-CMOS-compatible microphotonics platform which will enable on-chip imaging and sensing applications. Prior to coming to MIT she received her doctoral degree in Electrical Engineering from Boston University, where she investigated the spatial extent of point defect interactions in silicon.